

<b>Notice of References Cited</b>	Application/Control No. 10/709,543	Applicant(s)/Patent Under Reexamination WHIFFEN ET AL.	
	Examiner Michael D. Masinick	Art Unit 2125	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	"A Digital Measurement Station for RF-Conducted Emissions Monitoring" -Capua et al, IEEE Transactions on Instrumentation and Measurement, Vol 51, No. 6, IEEE December 2002.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.